

Notice of References Cited

Application/Control No.

10/516,642

Applicant(s)/Patent Under
Reexamination
THIERAUF ET AL.

Examiner

NICOLE HARRISON

Art Unit

4152

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,335,061 B1	01-2002	Kanamori et al.	427/515
*	B	US-5,451,390	09-1995	Hartmann et al.	423/610
*	C	US-6,908,879 B1	06-2005	Shima et al.	502/242
*	D	US-6,465,088 B1	10-2002	Talpaert et al.	428/307.3
*	E	US-6,074,981	06-2000	Tada et al.	502/224
*	F	US-6,013,372	01-2000	Hayakawa et al.	428/411.1
*	G	US-4,632,848	12-1986	Gosset et al.	427/154
*	H	US-5,616,532	04-1997	Heller et al.	502/242
*	I	US-4,252,569	02-1981	Roedel, George F.	106/287.16
*	J	US-4,076,868	02-1978	Roth et al.	427/348
*	K	US-5,595,813	01-1997	Ogawa et al.	428/212
*	L	US-6,037,289	03-2000	Chopin et al.	502/2
*	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 590477 A1	04-1994	European Patent	OGAWA et al.	
	O	JP 09313948 A	12-1997	Japan	MORI et al.	
	P	JP 09228545 A	09-1997	Japan	HAYAKAWA, MAKOTO	
	Q	JP 10237431 A	09-1998	Japan	KITAMURA et al.	
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	English Translation of JP 09313948
	V	English Translation of JP 09228545
	W	English Translation of JP 10237431
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.